

A measurement of the ϕ_{η}^* angle in Drell-Yan di-lepton pairs

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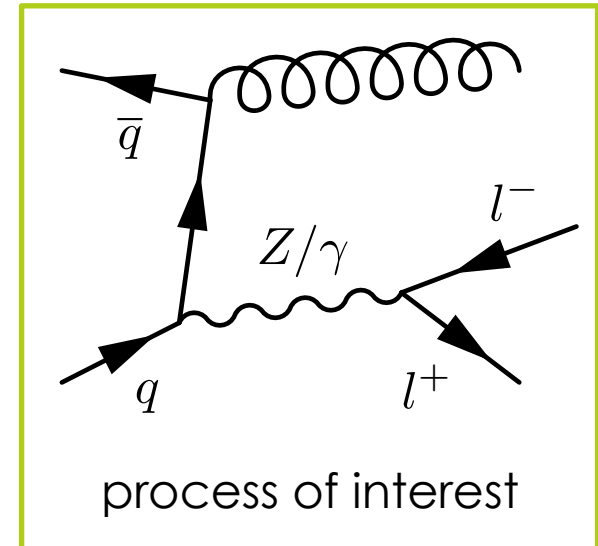
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Motivation

- Intermediate boson in Drell-Yan process can be produced with **non-zero transverse momentum**, p_T :
 - initial state gluon radiation

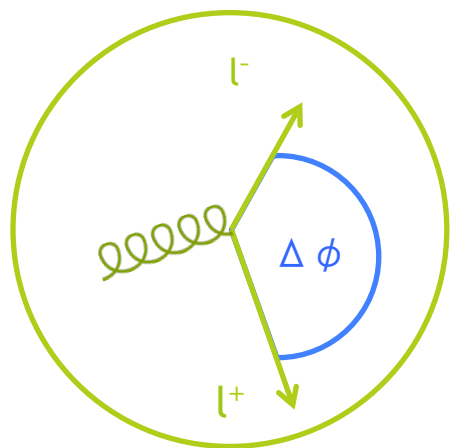
- Understanding this is important for:
 - testing **QCD predictions** (at low and high p_T)
 - **resummation** techniques
 - modelling **Z, W** and **Higgs production**



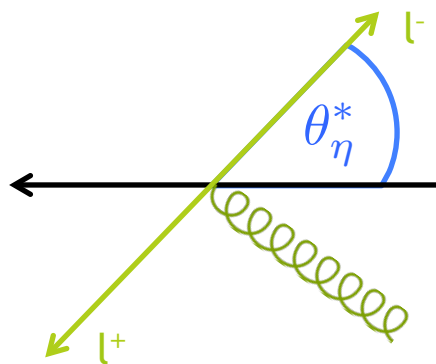
- Boson p_T measurement **limited experimentally** by **momentum resolution**
- Motivates introduction of ϕ_η^*

ϕ_η^* definition

define
$$\phi_\eta^* = \tan\left(\frac{\pi - \Delta\phi}{2}\right) \sin\theta_\eta^*$$



transverse plane

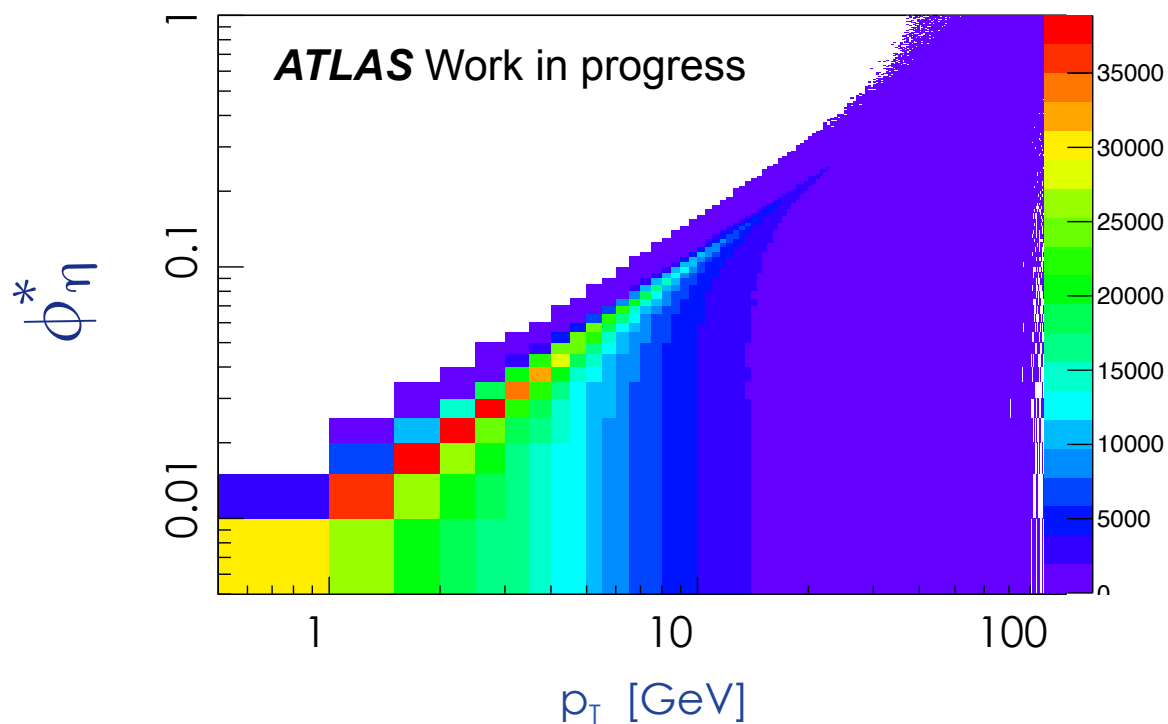


longitudinal plane
(**boson rest frame**)

$$\cos\theta_\eta^* = \tanh\frac{\eta^- - \eta^+}{2}$$

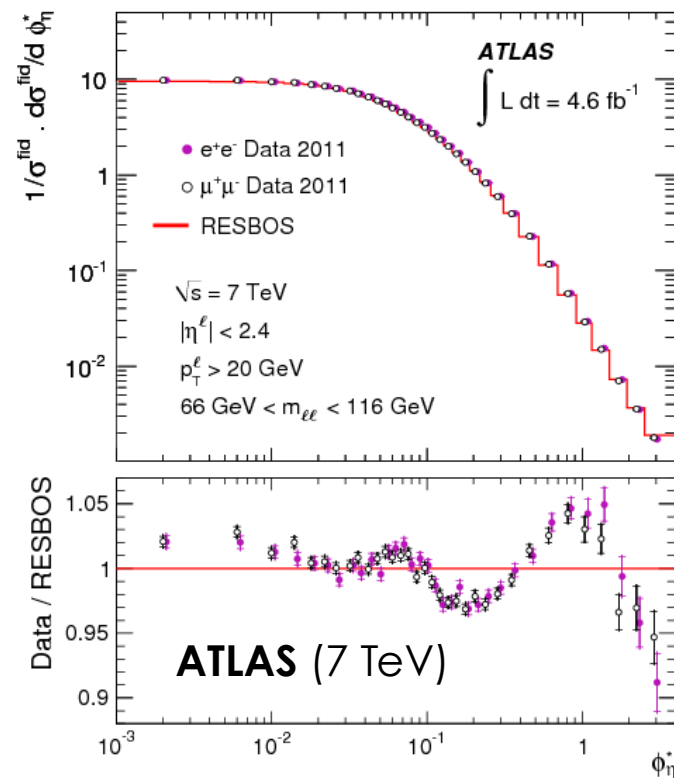
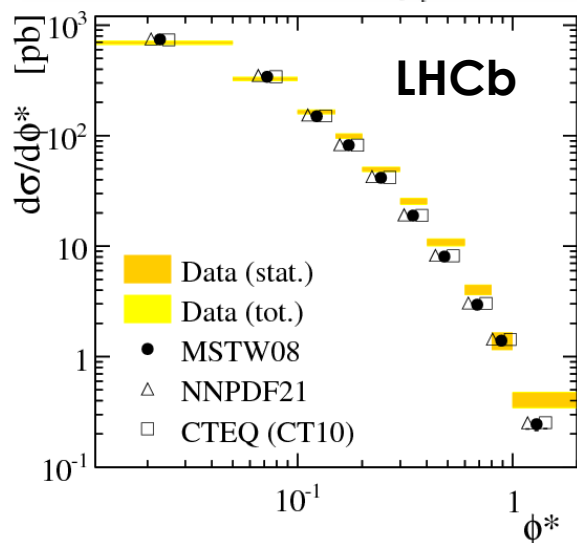
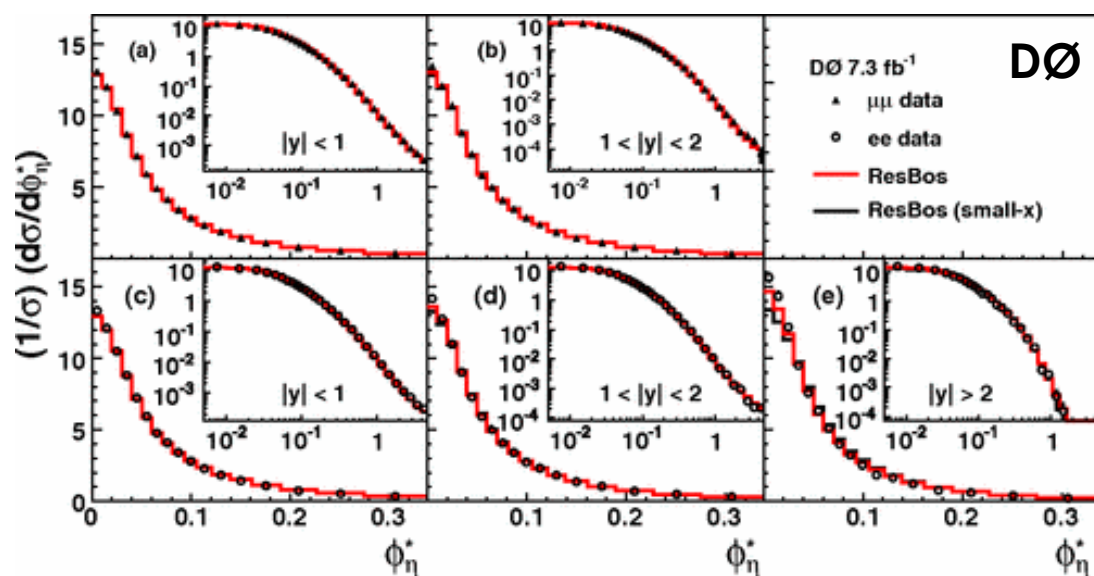
ϕ_η^* definition

- ✓ sensitive to boson p_T
- ✓ only relies on lepton directions: η, ϕ
- ✓ minimal dependence on momentum resolution



ϕ_η^* against p_T
 $66 \text{ GeV} < M_Z < 116 \text{ GeV}$

Previous measurements



- Used to tune Monte Carlo generators
 - RESBOS with DØ data (arXiv:1205.4311)
 - PYTHIA and POWHEG with ATLAS data (ATL-PHYS-PUB-2013-017)
- Also compared to NLO + NNLL calculation
 - Banfi et al. – J. High Energy Phys. 1201, 044; Phys. Lett. B715, 152

ATLAS 8 TeV measurement

- Measure **normalised triply differential cross section**

- in ϕ_η^* , **mass** (M) and **rapidity** (y)
- using 20.3 fb⁻¹ of 8 TeV data at ATLAS

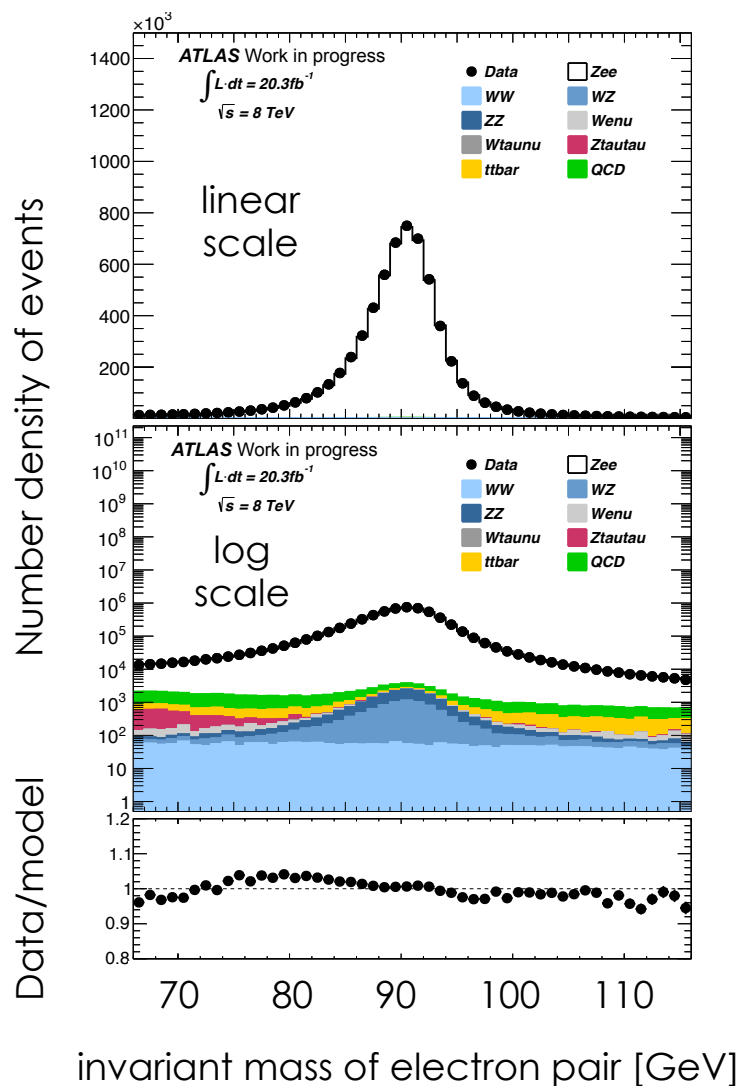
$$\frac{1}{\sigma} \frac{d^3\sigma}{d\phi_\eta^* dM dy}$$

- Perform measurement in **di-electron** and **di-muon** channels
 - and then **combine**
- Extension of the 7 TeV analysis - *Phys. Lett. B* 720 (2013) 32
 - measure ϕ_η^* **above** and **below Z-peak**
 - and in coarse **rapidity bins**
 - Extend to **higher** ϕ_η^* to benefit from **increased statistics**

Event selection

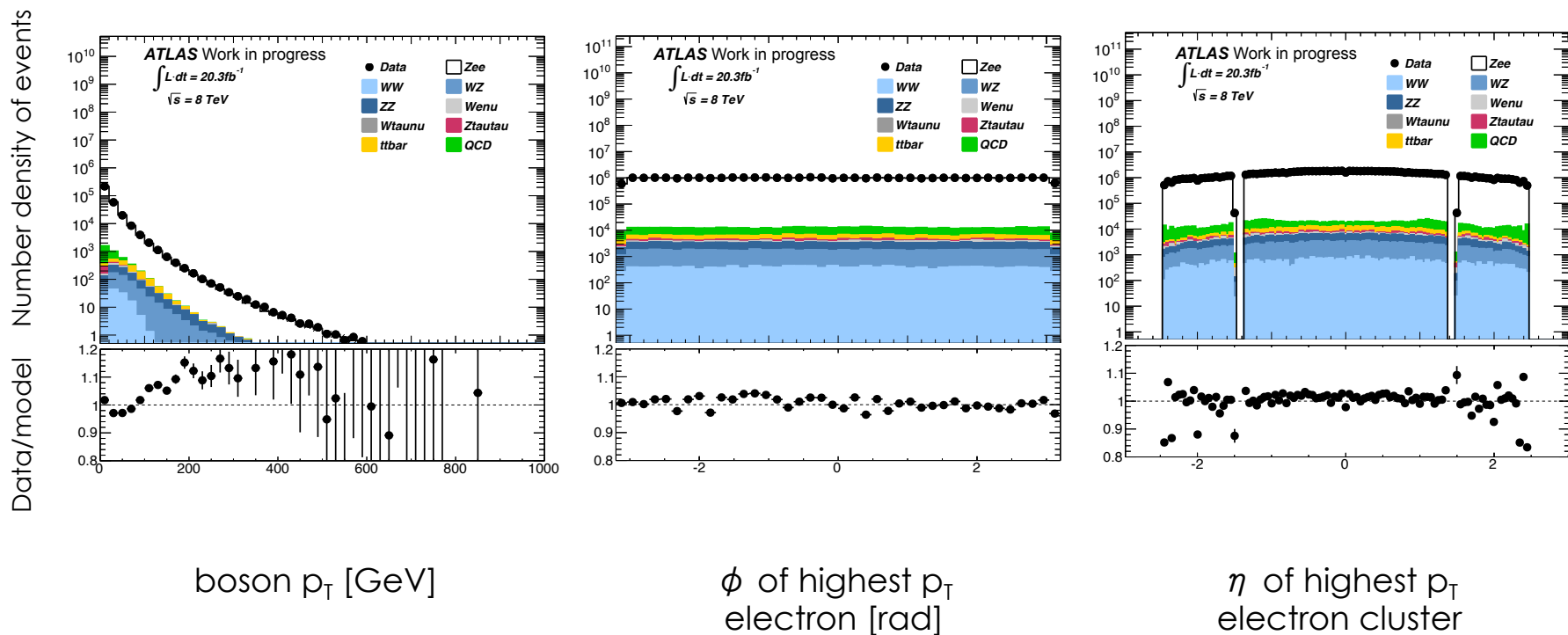
- Low background (~1% at Z peak)
 - minimal cuts required
 - signal modelled using Powheg + Pythia

- Di-lepton trigger
- Exactly two electrons / muons
 - passing quality and identification requirements
 - $p_T > 20$ GeV
 - geometric acceptance cuts



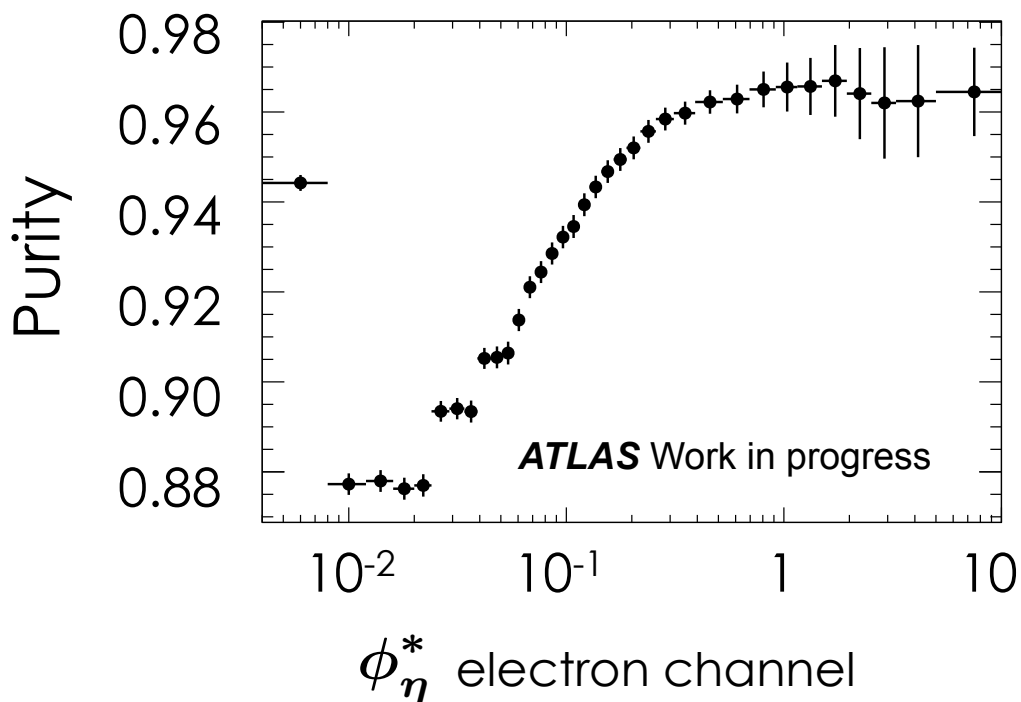
Data / model comparison

- Reasonable agreement between data and model in di-electron channel
- similar agreement seen in di-muon channel
- still work in progress



Binning

- Wide bins in mass and rapidity
- Binning in ϕ_η^* mostly influenced by detector **angular resolution**

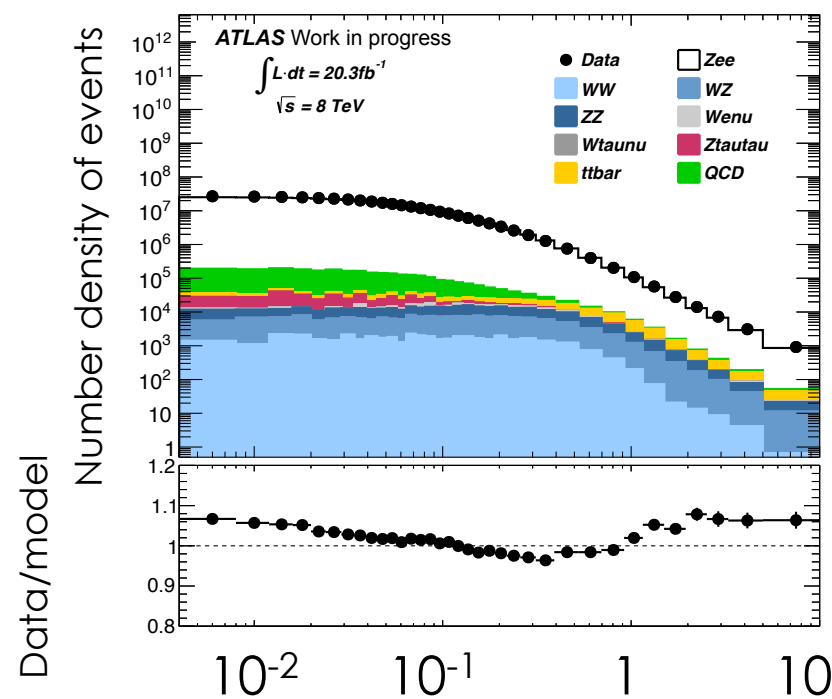
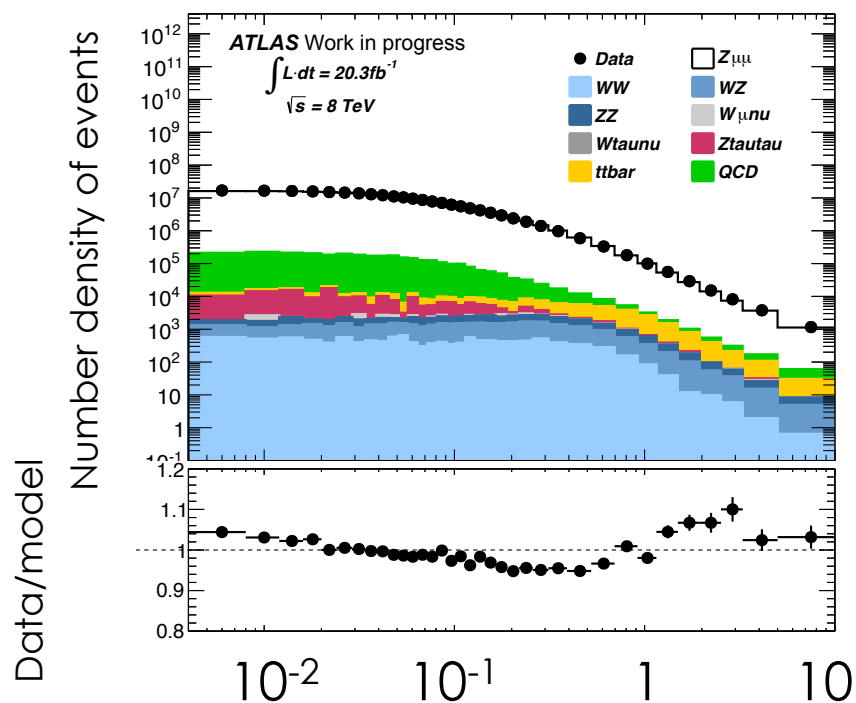


$$\text{purity} = \frac{\text{Number generated \& reconstructed in bin}}{\text{Number reconstructed in bin}}$$

ϕ_η^* distribution

- Reasonable agreement between data and model
- signal modelled using Powheg + Pythia
- will also compare to NLO + NNLL calculation (resummed)

$66 \text{ GeV} < M_Z < 116 \text{ GeV}$
 $0 < |\text{Rapidity}_Z| < 0.8$



Systematic uncertainties

- Dominant systematic uncertainties (based on 7 TeV analysis around the Z peak) expected to be from:
 - estimation of the number of background events from:
 - multi-jet / QCD background (estimation taken from data)
 - $t\bar{t}$, $Z/\gamma \rightarrow \tau^+\tau^-$, $W \rightarrow l\nu$, and di-boson processes
 - ($\sim 0.3\%$)
 - modelling of QED final state radiation ($\sim 0.3\%$)
 - important in correction of measured leptons to born, dressed and bare levels
 - modelling of detector angular resolution by Monte Carlo ($\sim 0.3\%$)
- Other uncertainties expected to be smaller
 - lepton identification and trigger efficiencies
 - pileup effects
 - method for correcting for detector effects

Summary

- ▣ Measuring triply differential cross section in ϕ_η^* , mass (M) and rapidity (y)

$$\frac{1}{\sigma} \frac{d^3\sigma}{d\phi_\eta^* dM dy}$$

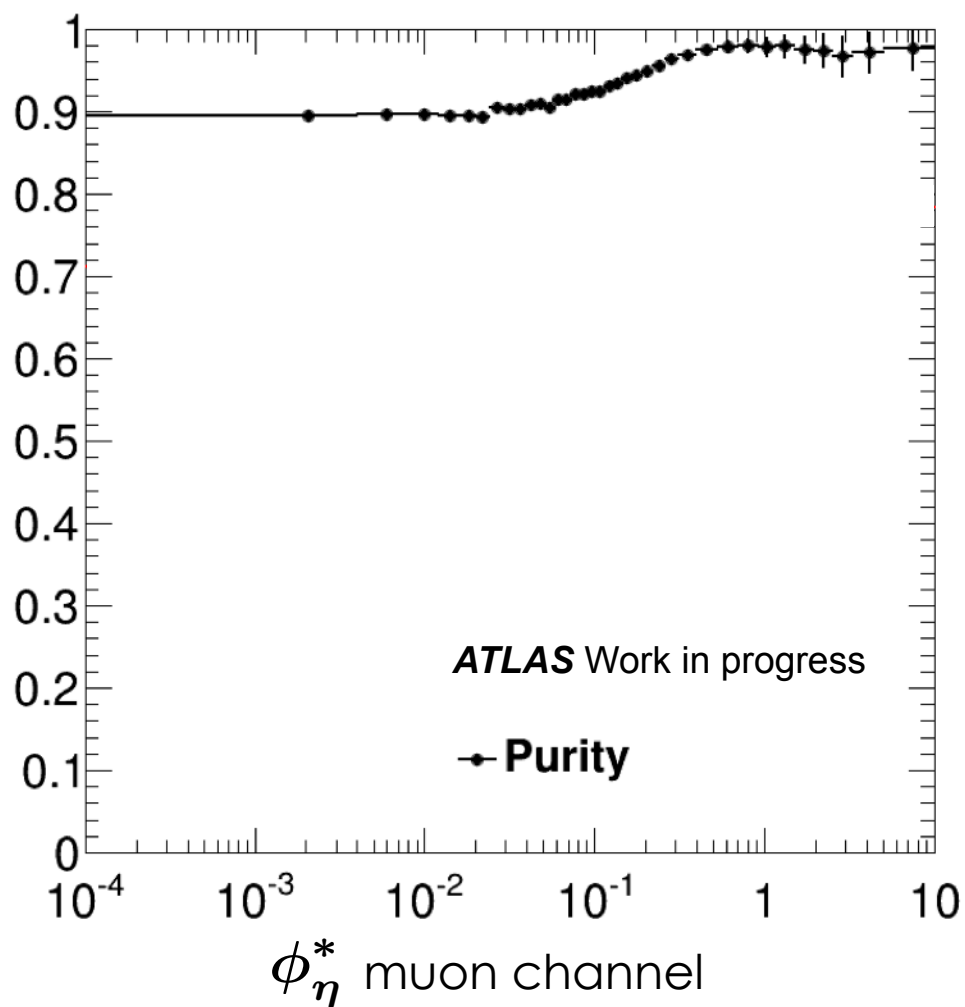
- ▣ Definition of ϕ_η^* relies only upon well measured lepton directions
 - ▣ A **complementary probe to p_T** of initial state radiation in Drell-Yan events

- ▣ Will correct data for **detector effects** and compare to NLO + NNLL resummed calculation

thanks to Lee Tomlinson and Terry Wyatt

Additional Material

Purity in di-muon channel



$$\text{purity} = \frac{\text{Number generated \& reconstructed in bin}}{\text{Number reconstructed in bin}}$$